

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ISHII ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0042466	02-2005	Ohno et al.	428/457
	B	US-2004/0132941	07-2004	Ishii et al.	526/319
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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